

Notice of References Cited

Application/Control No.

10/750,436

Applicant(s)/Patent Under
Reexamination
DEB ET AL.

Examiner

MARK A. FLEISCHER

Art Unit

3624

Page 1 of 1

U.S. PATENT DOCUMENTS

*	Document Number		Date	Name	Classification
	Country Code-Number-Kind Code		MM-YYYY		
*	A	US-2004/0002988 A1	01-2004	Seshadri et al.	707/102
*	B	US-7,236,950 B2	06-2007	Savage et al.	705/34
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*	Document Number		Date	Country	Name	Classification
	Country Code-Number-Kind Code		MM-YYYY			
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*	Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)				
U					
V					
W					
X					

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
 Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.